Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/620,116	HORVITZ, ERIC	
Examiner	Art Unit	

Isaac M. Woo

2166

SEARCHED					
Class	Subclass	Date	Examiner		
707	1-10	9/25/2007	IW		
707	100-104.1	9/25/2007	IW		
707	200-206	9/25/2007	IW		
709	204-207	9/25/2007	IW		
709	238-244	9/25/2007	IW '		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
search - S	JSPAT text See history printout	9/25/2007	IW	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
See search history printout(s), ACM, IEEE, Google	9/25/2007	IW
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